

Features

- 1) Low on-resistance
- 2) Fast switching speed
- 3) Fast reverse recovery
- 4) Easy to parallel
- 5) Simple to drive
- 6) Pb-free lead plating ; RoHS compliant

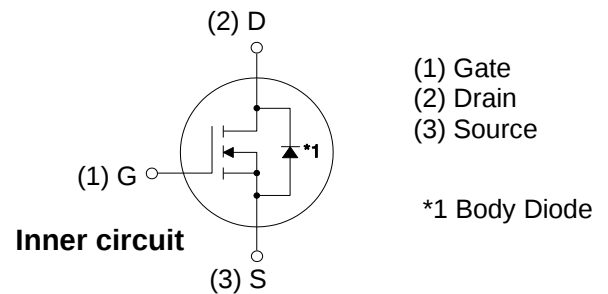
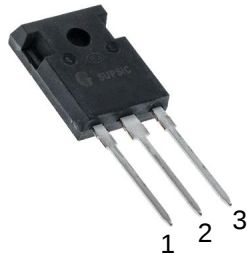
Parameter	Rating	Units
V_{DS}	650	V
I_D @ 25°C	50	A
$R_{DS(on)}$	45	m Ω



Applications

- Solar inverters
- DC/DC converters
- Switch mode power supplies
- Induction heating

T0-247-3
Package



Maximum Ratings

Symbol	Parameter	Value	Unit	Note
V_{DSS}	Drain - Source Voltage, $T_C = 25^\circ\text{C}$	650	V	
V_{GS}	Gate - Source voltage (Under transient events < 100 ns)	-8/+19	V	
I_D	Continuous Drain Current, $V_{GS} = 15\text{ V}$, $T_C = 25^\circ\text{C}$	50	A	
	Continuous Drain Current, $V_{GS} = 15\text{ V}$, $T_C = 100^\circ\text{C}$	35		
$I_{D(pulse)}$	Pulsed Drain Current, Pulse width t_p limited by T_{Jmax}	134	A	
P_D	Power Dissipation, $T_C=25^\circ\text{C}$, $T_J = 175^\circ\text{C}$	178	W	
T_J, T_{stg}	Operating Junction and Storage Temperature	-40 to +175	$^\circ\text{C}$	
T_L	Solder Temperature, 1.6mm (0.063") from case for 10s	260	$^\circ\text{C}$	
M_d	Mounting Torque, (M3 or 6-32 screw)	1 8.8	Nm lbf-in	

**Electrical Characteristics** ($T_C = 25^\circ\text{C}$ unless otherwise specified)

Symbol	Parameter	Min.	Typ.	Max.	Unit	Test Conditions	Note
$V_{(BR)DSS}$	Drain-Source Breakdown Voltage	650			V	$V_{GS} = 0\text{ V}, I_D = 100\text{ }\mu\text{A}$	
V_{GSon}	Gate-Source Recommended Turn-On Voltage		15		V	Static	
V_{GSoff}	Gate-Source Recommended Turn-Off Voltage		-4		V		
$V_{GS(th)}$	Gate Threshold Voltage	1.8	2.6	3.6	V	$V_{DS} = V_{GS}, I_D = 4.84\text{ mA}$	
			2.2		V	$V_{DS} = V_{GS}, I_D = 4.84\text{ mA}, T_J = 175^\circ\text{C}$	
I_{DSS}	Zero Gate Voltage Drain Current		1	50	μA	$V_{DS} = 650\text{ V}, V_{GS} = 0\text{ V}$	
I_{GSS}	Gate-Source Leakage Current		10	250	nA	$V_{GS} = 15\text{ V}, V_{DS} = 0\text{ V}$	
$R_{DS(on)}$	Drain-Source On-State Resistance		45	60	m Ω	$V_{GS} = 15\text{ V}, I_D = 17.6\text{ A}$	
			60			$V_{GS} = 15\text{ V}, I_D = 17.6\text{ A}, T_J = 175^\circ\text{C}$	
g_{fs}	Transconductance		12		S	$V_{DS} = 20\text{ V}, I_{DS} = 17.6\text{ A}$	
			11			$V_{DS} = 20\text{ V}, I_{DS} = 17.6\text{ A}, T_J = 175^\circ\text{C}$	
C_{iss}	Input Capacitance		1520		pF	$V_{GS} = 0\text{ V}, V_{DS} = 400\text{ V}$ $F = 1\text{ MHz}$ $V_{AC} = 25\text{ mV}$	
C_{oss}	Output Capacitance		182				
C_{rss}	Reverse Transfer Capacitance		8				
$C_{o(er)}$	Effective Output Capacitance (Energy Related)		126				
$C_{o(tr)}$	Effective Output Capacitance (Time Related)		182				
E_{oss}	C_{oss} Stored Energy		20		μJ	$V_{DS} = 600\text{ V}, F = 1\text{ MHz}$	
E_{ON}	Turn-On Switching Energy (Body Diode)		210		μJ	$V_{DS} = 400\text{ V}, V_{GS} = -4\text{ V}/15\text{ V}, I_D = 17.6\text{ A},$ $R_{G(ext)} = 2.5\text{ }\Omega, L = 99\text{ }\mu\text{H}, T_J = 175^\circ\text{C}$ FWD = Internal Body Diode of MOSFET	
E_{OFF}	Turn Off Switching Energy (Body Diode)		42				
E_{ON}	Turn-On Switching Energy (External Diode)		163		μJ	$V_{DS} = 400\text{ V}, V_{GS} = -4\text{ V}/15\text{ V}, I_D = 17.6\text{ A},$ $R_{G(ext)} = 2.5\text{ }\Omega, L = 99\text{ }\mu\text{H}, T_J = 175^\circ\text{C}$ FWD = External SiC DIODE	
E_{OFF}	Turn Off Switching Energy (External Diode)		42				
$t_{d(on)}$	Turn-On Delay Time		11		ns	$V_{DD} = 400\text{ V}, V_{GS} = -4\text{ V}/15\text{ V}$ $I_D = 17.6\text{ A}, R_{G(ext)} = 2.5\text{ }\Omega, L = 99\text{ }\mu\text{H}$ Timing relative to V_{DS} Inductive load	
t_r	Rise Time		32				
$t_{d(off)}$	Turn-Off Delay Time		20				
t_f	Fall Time		8				
$R_{G(int)}$	Internal Gate Resistance		3		Ω	$f = 1\text{ MHz}, V_{AC} = 25\text{ mV}$	
Q_{gs}	Gate to Source Charge		21		nC	$V_{DS} = 400\text{ V}, V_{GS} = -4\text{ V}/15\text{ V}$ $I_D = 17.6\text{ A}$ Per IEC60747-8-4 pg 21	
Q_{gd}	Gate to Drain Charge		20				
Q_g	Total Gate Charge		61				

Note (1): $C_{o(er)}$, a lumped capacitance that gives same stored energy as C_{oss} while V_{ds} is rising from 0 to 400V
 $C_{o(tr)}$, a lumped capacitance that gives same charging time as C_{oss} while V_{ds} is rising from 0 to 400V



Reverse Diode Characteristics ($T_c = 25^\circ\text{C}$ unless otherwise specified)

Symbol	Parameter	Typ.	Max.	Unit	Test Conditions	Note
V_{SD}	Diode Forward Voltage	4.8		V	$V_{GS} = -4\text{ V}, I_{SD} = 8.8\text{ A}, T_J = 25^\circ\text{C}$	
		4.2		V	$V_{GS} = -4\text{ V}, I_{SD} = 8.8\text{ A}, T_J = 175^\circ\text{C}$	
I_S	Continuous Diode Forward Current		29	A	$V_{GS} = -4\text{ V}, T_c = 25^\circ\text{C}$	
$I_{S, \text{pulse}}$	Diode pulse Current		132	A	$V_{GS} = -4\text{ V}$, pulse width t_p limited by T_{Jmax}	
t_{rr}	Reverse Recover time	26		ns	$V_{GS} = -4\text{ V}, I_{SD} = 17.6\text{ A}, V_R = 400\text{ V}$ $dif/dt = 1220\text{ A}/\mu\text{s}, T_J = 175^\circ\text{C}$	
Q_{rr}	Reverse Recovery Charge	171		nC		
I_{rrm}	Peak Reverse Recovery Current	11		A		
t_{rr}	Reverse Recover time	34		ns	$V_{GS} = -4\text{ V}, I_{SD} = 17.6\text{ A}, V_R = 400\text{ V}$ $dif/dt = 850\text{ A}/\mu\text{s}, T_J = 175^\circ\text{C}$	
Q_{rr}	Reverse Recovery Charge	158		nC		
I_{rrm}	Peak Reverse Recovery Current	8		A		

Thermal Characteristics

Symbol	Parameter	Typ.	Unit	Test Conditions	Note
$R_{\theta JC}$	Thermal Resistance from Junction to Case	0.85	$^\circ\text{C}/\text{W}$		
$R_{\theta JA}$	Thermal Resistance From Junction to Ambient	40			

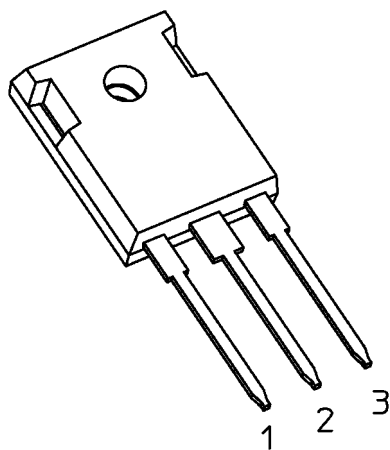


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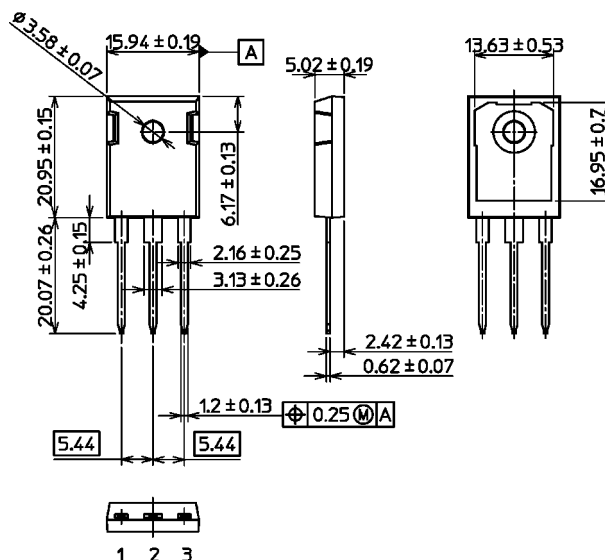
AC3M0045065D
Silicon Carbide Power MOSFET
N-Channel Enhancement Mode

Package Dimensions

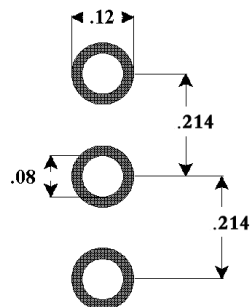
Unit: mm



TO-247-3



Recommended Solder Pad Layout



TO-247-3